

# Initial Product/Process Change Notification

Document #:IPCN25451Z Issue Date:17 May 2023

Title of Change:	Qualification of onsemi Aizu Japan as wafer Fab for ONC25 Technology for select products from NCV20061, NCV20081, NCV20091 and NCV20062, NCV20082, NCV20092.	
Proposed Changed Material First Ship Date:	26 Apr 2024 or earlier if approved by customer	
Current Material Last Order Date:	N/A Orders received after the Current Material Last Order Date expiration are to be considered as orders for new changed material as described in this PCN. Orders for current (unchanged) material after this date will be per mutual agreement and current material inventory availability.	
Current Material Last Delivery Date:	N/A The Current Material Last Delivery Date may be subject to change based on build and depletion of the current (unchanged) material inventory	
Product Category:	Active components – Integrated circuits	
Contact information:	Contact your local onsemi Sales Office or Adrian.Croitoru@onsemi.com	
PCN Samples Contact:	Contact your local onsemi Sales Office to place sample order.  Sample requests are to be submitted no later than 45 days after publication of this change notification.  Samples delivery timing will be subject to request date, sample quantity and special customer packing/label requirements.	
Additional Reliability Data:	Contact your local onsemi Sales Office or Vladislav.Hrachovec@onsemi.com	
Type of Notification:	This is an Initial Product/Process Change Notification (IPCN) sent to customers. An IPCN is an advance notification about an upcoming change and contains general information regarding the change details and devices affected. It also contains the preliminary reliability qualification plan. The completed qualification and characterization data will be included in the Final Product/Process Change Notification (FPCN). This IPCN notification will be followed by a Final Product/Process Change Notification (FPCN) at least 6 months prior to implementation of the change. In case of questions, contact < <a href="mailto:PCN.Support@onsemi.com">PCN.Support@onsemi.com</a> >.	
Change Category		
Category	Type of Change	
Process - Wafer Production	Move of all or part of wafer fab to a different location/site/subcontractor	
Process - Assembly	Change of wire bonding	

### **Description and Purpose:**

onsemi would like to inform its customers of qualification of an additional wafer fabrication facility for ONC25 technology at onsemi Aizu, Japan for the devices listed in this IPCN, and wire conversion from Au to Pd-Coated Copper(PCC).

All products listed here will be sourced only from onsemi Aizu.

There is no change to the orderable part number.

There is no product marking change as a result of this notification.

NCV20061.NCV20081.NCV20091 Products – All packages	From	То
Wafer Fab	onsemi, Gresham, Oregon (US)	onsemi, Aizu (Japan)
Bond Wire	0.8mil Au	0.8mil Pd-Coated Copper (PCC)

TEM001791 Rev. H Page 1 of 4



# Initial Product/Process Change Notification

Document #:IPCN25451Z Issue Date:17 May 2023

NCV20062.NCV20082.NCV20092 Products - under SOIC-8 and TSSOP-8 packages	From	То
Wafer Fab	onsemi, Gresham, Oregon (US)	onsemi, Aizu (Japan)
Back Grinding	onsemi, Gresham, Oregon (US)	onsemi, ISMF Seremban
Bond Wire	0.8mil Au	1mil Pd-Coated Copper (PCC)

NCV20062.NCV20082.NCV20092 Products under MICRO-8 package	From	То
Wafer Fab	onsemi, Gresham, Oregon (US)	onsemi, Aizu (Japan)
Back Grinding	onsemi, Gresham, Oregon (US)	onsemi, ISMF Seremban
Bond Wire	1mil Au	1mil Pd-Coated Copper (PCC)

Reason / Motivation for Change:	Process/Materials Change
Anticipated impact on fit, form, function, reliability, product safety or manufacturability:	The device will be qualified and validated based on the same Product Specification.  No anticipated impacts.

#### **Sites Affected:**

onsemi Sites	External Foundry/Subcon Sites
onsemi Aizu, Japan	None
onsemi Carmona, Philippines	
onsemi Seremban, Malaysia	
onsemi, ISMF Malaysia	

## Marking of Parts/ Traceability of Change:

Custom source information will be updated on product label. Product traceability will be identified by encoded date code.

## **Reliability Data Summary:**

QV DEVICE NAME: NCV20061SQ3T2G, NCV20061SN2T1G

RMS: S90292, S90294, S90295 PACKAGE: SC-88A, TSOP-5

Test	Specification	Condition	Interval
High Temperature Operating Life	JESD22-A108	Ta=125°C, 100 % max rated Vcc	1008 hrs
High Temperature Storage Life	JESD22-A103	Ta= 150°C	1008 hrs
Preconditioning	J-STD-020 JESD-A113	MSL 1 @ 260°C	
Temperature Cycling	JESD22-A104	Ta= -55°C to +150°C	1000 cyc
Highly Accelerated Stress Test	JESD22-A110	130°C, 85% RH, 18.8psig, bias	96 hrs
Unbiased Highly Accelerated Stress Test	JESD22-A118	130°C, 85% RH, 18.8psig, unbiased	96 hrs
Solderability	JSTD002	Ta = 245°C, 5 sec	
Physical Dimensions	JESD22-B120		

TEM001791 Rev. H Page 2 of 4



# Initial Product/Process Change Notification

Document #:IPCN25451Z Issue Date:17 May 2023

QV DEVICE NAME: NCV20062DR2G, NCV20082DR2G, NCV20092DR2G

RMS: O90248, O90249, O90250

PACKAGE: SOIC-8

Test	Specification	Condition	Interval
High Temperature Operating Life	JESD22-A108	Ta=125°C, 100 % max rated Vcc	1008 hrs

QV DEVICE NAME: NCV20062DMR2G, NCV20062DR2G, NCV20062DTBR2G

RMS: O90251, 90252, 90255

PACKAGE: MICRO-8, SOIC-8, TSSOP-8

Test	Specification	Condition	Interval
High Temperature Storage Life	JESD22-A103	Ta= 150°C	1008 hrs
Preconditioning	J-STD-020 JESD-A113	MSL 1 @ 260°C	
Temperature Cycling	JESD22-A104	Ta= -55°C to +150°C	1000 cyc
Highly Accelerated Stress Test	JESD22-A110	130°C, 85% RH, 18.8psig, bias	96 hrs
Unbiased Highly Accelerated Stress Test	JESD22-A118	130°C, 85% RH, 18.8psig, unbiased	96 hrs
Solderability	JSTD002	Ta = 245°C, 5 sec	
Physical Dimensions	JESD22-B120		

Estimated date for qualification completion: 11 October 2023

#### **Electrical Characteristics Summary:**

Electrical characteristics are not impacted.

#### **List of Affected Parts:**

**Note:** Only the standard (off the shelf) part numbers are listed in the parts list. Any custom parts affected by this PCN are shown in the customer specific PCN addendum in the PCN email notification, or on the <u>PCN Customized Portal</u>.

Current Part Number	New Part Number	Qualification Vehicle
NCV20061SN3T1G	NA	NCV20061SN2T1G
NCV20061SN2T1G	NA	NCV20061SN2T1G
NCV20061SQ3T2G	NA	NCV20061SQ3T2G
NCV20081SN3T1G	NA	NCV20061SN2T1G
NCV20081SN2T1G	NA	NCV20061SN2T1G
NCV20081SQ3T2G	NA	NCV20061SQ3T2G
NCV20081SQ2T2G	NA	NCV20061SQ3T2G
NCV20091SN3T1G	NA	NCV20061SN2T1G
NCV20091SN2T1G	NA	NCV20061SN2T1G

TEM001791 Rev. H Page 3 of 4



# Initial Product/Process Change Notification Document #:IPCN25451Z Issue Date:17 May 2023

NCV20091SQ3T2G	NA	NCV20061SQ3T2G
NCV20062DMR2G	NA	NCV20062DMR2G
NCV20062DR2G	NA	NCV20062DR2G
NCV20062DTBR2G	NA	NCV20062DTBR2G
NCV20082DMR2G	NA	NCV20062DMR2G
NCV20082DR2G	NA	NCV20062DR2G
NCV20082DTBR2G	NA	NCV20062DTBR2G
NCV20092DMR2G	NA	NCV20062DMR2G
NCV20092DR2G	NA	NCV20062DR2G
NCV20092DTBR2G	NA	NCV20062DTBR2G

TEM001791 Rev. H Page 4 of 4